

N-Ch and P-Channel MOSFET

General Description

The WSF3015 is the highest performance trench N-ch and P-ch MOSFETs with extreme high cell density, which provide excellent RDSON and gate charge for most of the synchronous buck converter applications.

The WSF3015 meet the RoHS and Green Product requirement 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Absolute Maximum Ratings

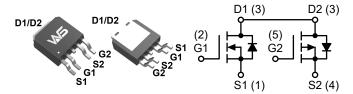
Product Summery

BV _{DSS}	R _{DSON}	I _D
30V	15mΩ	22A
-30V	25mΩ	-19A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- CCFL Back-light Inverter

TO-252-4L Pin Configuration



Symbol	Parameter	Rati	Units	
Gymbol	i didiletti	N-Ch	P-Ch	Units
V _{DS}	Drain-Source Voltage	30	-30	V
V _{GS}	Gate-Source Voltage	±20	±20	V
L.	Continuous Drain Current, V _{GS(NP)} =10V,T _c =25 C	22	-19	А
ID	Continuous Drain Current, V _{GS(NP)} =10V,T _c =100 [°] C	10	-8	A
I _{DP} ^a	Pulse Drain Current Tested, V _{GS(NP)} =10V	52	-45	A
E _{AS} ^c	Avalanche Energy, Single pulse , L=0.5mH	22	45	mJ
I _{AS} ^c	Avalanche Current, Single pulse , L=0.5mH	21	-30	A
PD	Total Power Dissipation, T _c =25 [°] C	18	18	W
T _{STG}	Storage Temperature Range	-55 to 150	-55 to 150	Ĉ
TJ	Operating Junction Temperature Range	150	150	°C
R _{eJA} ^b	Thermal Resistance-Junction to Ambient, Steady State	62	62	°C/W
$R_{ ext{ heta}JC}$	Thermal Resistance-Junction to Case, Steady State	5.0	5.0	°C/W

Note * : Max. current is limited by bonding wire.

Note a : Pulse width limited by max. junction temperature.

Note b : $R_{\theta JA}$ steady state t=999s. $R_{\theta JA}$ is measured with the device mounted on 1in², FR-4 board with 2oz. Copper.

Note c : UIS tested and pulse width limited by maximum junction temperature 150° C (initial temperature $T_j=25^{\circ}$ C).



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N-Channel Electrical Characteristics ÁQ/JMÁGÍ »ÔÁW; |^••ÁJc@¦, ã^Áp[c^åD

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
Dd	Static Drain-Source On-Resistance	V _{GS} =10V , I _D =10A	15 22		22	- mΩ
R _{DS(ON)} ^d	Static Drain-Source On-Resistance	V _{GS} =4.5V , I _D =5A 2		20	30	
V _{GS(th)}	Gate Threshold Voltage	V_{GS} = V_{DS} , I_D =250 uA	1.0	1.6	2.5	V
la a a	Drain Source Lookage Current	V_{DS} =20V , V_{GS} =0V , T_{J} =25 $^{\circ}$ C			1	
IDSS	Drain-Source Leakage Current	V_{DS} =20V , V_{GS} =0V , T_{J} =85 $^{\circ}$ C			30	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
R _g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.5	5.0	Ω
Qg ^e	Total Gate Charge			7.2		
Q _{gs} e	Gate-Source Charge	V _{DS} =20V, V _{GS} =4.5V. I _{DS} =10A		1.4		nC
Q _{gd} e	Gate-Drain Charge			2.2		
T _{d(on)} e	Turn-On Delay Time			4.1		
T _r e	Rise Time	V _{DD} =15V, I _{DS} =5A,		9.8		
T _{d(off)} e	Turn-Off Delay Time	V _{GS} =10V, R _G =3.3R.		15.5		ns
T _f e	Fall Time			6.0		
C _{iss} e	Input Capacitance			572		
C _{oss} ^e	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		81		pF
C _{rss} e	Reverse Transfer Capacitance			65		

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	$V_G=V_D=0V$, Force Current			10	А
V_{SD}^{d}	Diode Forward Voltage	V _{GS} =0V , I _S =1A , T _J =25℃			1.2	V

Note d : Pulse test ; pulse width \leq 300µs, duty cycle \leq 2%.

Note e : Guaranteed by design, not subject to production testing.



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P-Channel Electrical Characteristics Áŷ/JMÁGÍ »ÔÁ\} |^••ÁJc@¦, ã^Áp[c^åD

Symbol	Parameter	Parameter Conditions		Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage V _{GS} =0V , I _D =-250uA		-30			V	
R _{DS(ON)} ^d	Static Drain-Source On-Resistance	V _{GS} =-10V , I _D =-7A	25 33		33		
TNDS(ON)	Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-5A	37 54 m		mΩ		
V _{GS(th)}	Gate Threshold Voltage	$V_{GS}=V_{DS}$, $I_D = -250 uA$	-1.0		-2.8	V	
IDSS	Drain-Source Leakage Current	$V_{\text{DS}}\text{=-20V}$, $V_{\text{GS}}\text{=}0\text{V}$, $T_{\text{J}}\text{=}25^\circ\!\!\mathrm{C}$			-1	- uA	
1055		V_{DS} =-20V , V_{GS} =0V , T_{J} =85 $^{\circ}$ C			-30	u u u u u u u u u u u u u u u u u u u	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA	
Qg ^e	Total Gate Charge			9.8		nC	
Q _{gs} e	Gate-Source Charge	V_{DS} =-15V , V_{GS} =-4.5V , I_{D} =-12A		2.2			
Q _{gd} e	Gate-Drain Charge			3.4			
T _{d(on)} e	Turn-On Delay Time			16.4			
Tre	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_G =6 Ω ,		20.2			
T _{d(off)} e	Turn-Off Delay Time	elay Time I_D =-1A ,RL=15 Ω ,		55		ns	
Tf ^e	Fall Time			10			
C _{iss} e	Input Capacitance			930			
C _{oss} ^e	C _{oss} ^e Output Capacitance V _{DS} =-15V , V _{GS} =0V , f=			148		pF	
C _{rss} ^e	Reverse Transfer Capacitance			115			

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	$V_G=V_D=0V$, Force Current			-8	А
V _{SD} e	Diode Forward Voltage	$V_{GS}\text{=}0V$, $I_{S}\text{=}\text{-}1A$, $T_{J}\text{=}25^{\circ}\!\!\!\mathrm{C}$			-1.2	V

Note d : Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2%.

Note e : Guaranteed by design, not subject to production testing.



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N-Channel Typical Characteristics

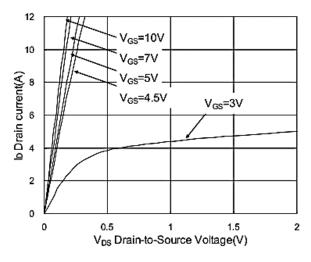


Fig.1 Typical Output Characteristics

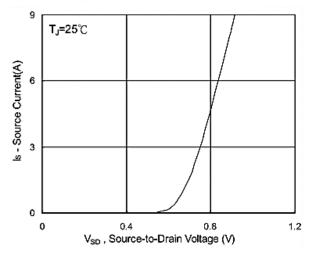


Fig.3 Forward Characteristics Of Reverse

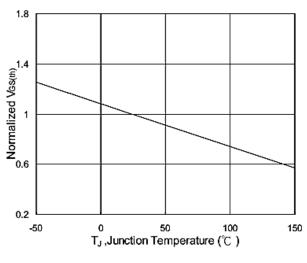


Fig.5 Normalized V_{GS(th)} v.s T_J

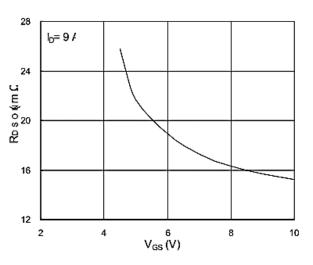


Fig.2 On-Resistance v.s Gate-Source

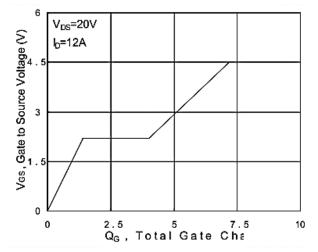


Fig.4 Gate-Charge characteristics

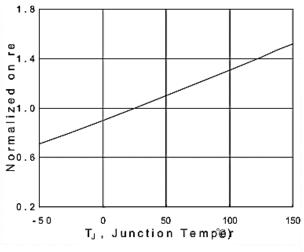


Fig.6 Normalized RDSON v.s TJ



N-Ch and P-Channel MOSFET

N-Channel Typical Characteristics (Cont.)

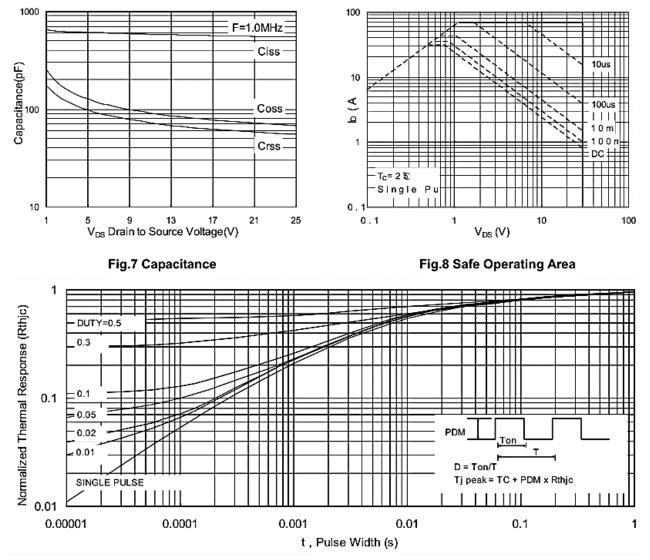


Fig.9 Normalized Maximum Transient Thermal Impedance

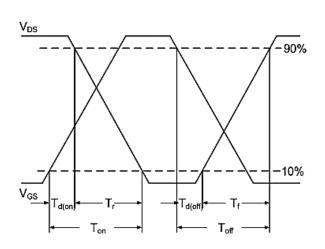


Fig.10 Switching Time Waveform

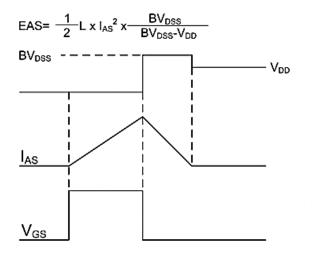
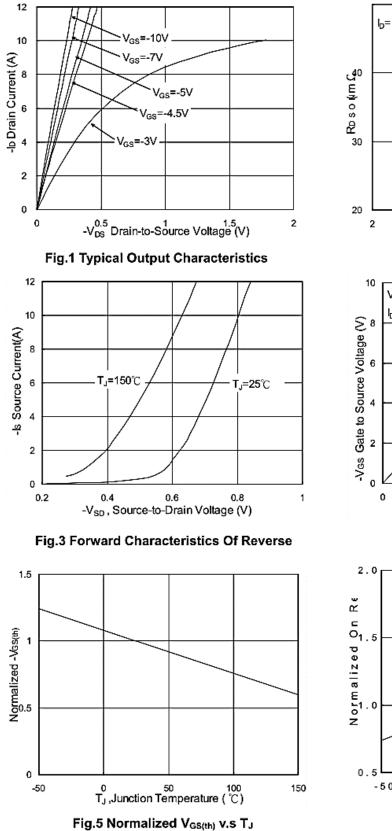


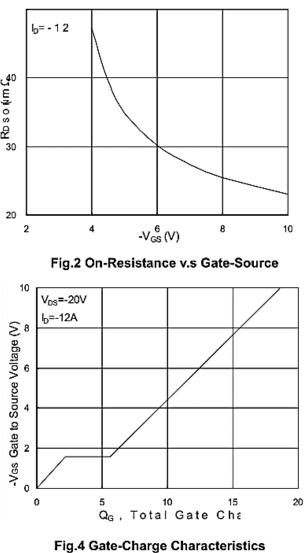
Fig.11 Unclamped Inductive Waveform



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P-Channel Typical Characteristics





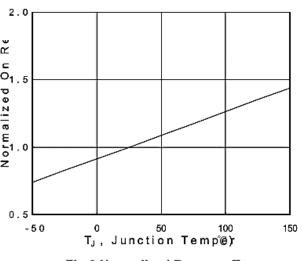
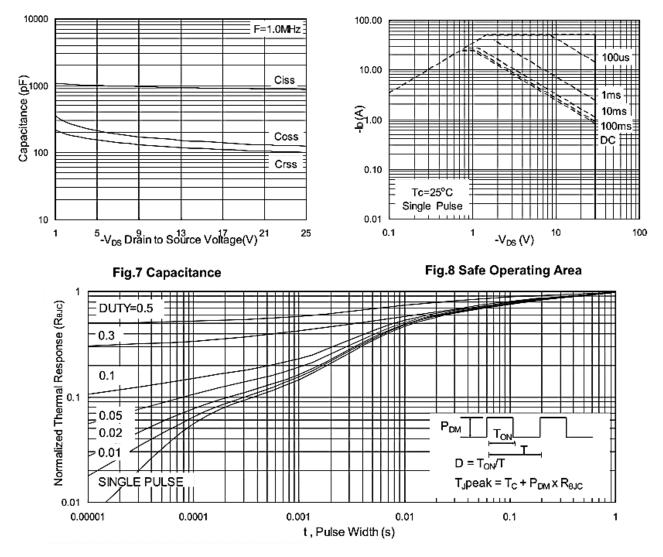


Fig.6 Normalized RDSON v.s TJ

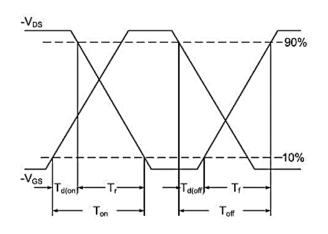


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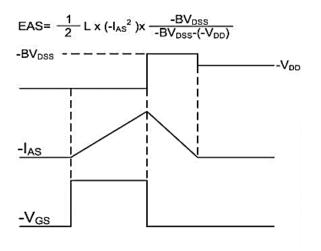
P-Channel Typical Characteristics (Cont.)









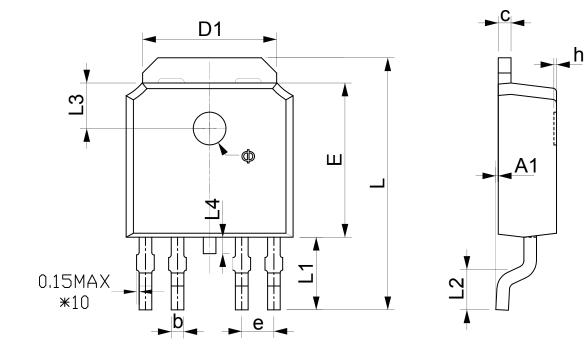


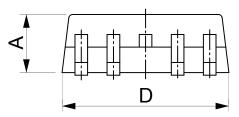




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Packaging information





Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
A	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.400	0.600			
С	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	4.830 REF.		0.190	REF.	
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.712	10.312	0.382	0.406	
L1	2.900 REF.		0.114	REF.	
L2	1.400	1.700	0.055	0.067	
L3	1.600	REF.	0.063 REF.		
L4	0.600	1.000	0.024	0.039	
Φ	1.100	1.300	0.043	0.051	
h	0.000	0.300	0.000	0.012	



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